

Search Notes (continued)**Application/Control No.**

10/734,870

**Applicant(s)/Patent under
Reexamination**

LEEK ET AL.

Examiner

Jeanette E. Chapman

Art Unit

3633

SEARCHED

Class	Subclass	Date	Examiner
52	798.1	6/20/2008	JC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR